

FORM PTO 1449 (modified)

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICELIST OF REFERENCES CITED BY APPLICANT(S)
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Date Submitted to PTO: January 24, 2002

ATTY DOCKET NO.
2002-0069

SERIAL NO.

APPLICANT
Toshikazu TACHIKAWA et al.FILING DATE
January 24, 2002

GROUP

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
PK	AA	6,010,829	1/2000	Rogers et al.			
KA	AB	6,042,988	3/2000	Sato et al.			
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
RA	AI	1 604 954	12-16-81	Great Britain			
	AJ	62-229942	10-8-87	Japan			Abstract
	AK	2-120366	5-8-90	Japan			Abstract
	AL	2-15270	1-18-90	Japan			Abstract
	AM	1-293339	11-27-89	Japan			Abstract
TUA	AN	9-160259	6-20-97	Japan			Abstract

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

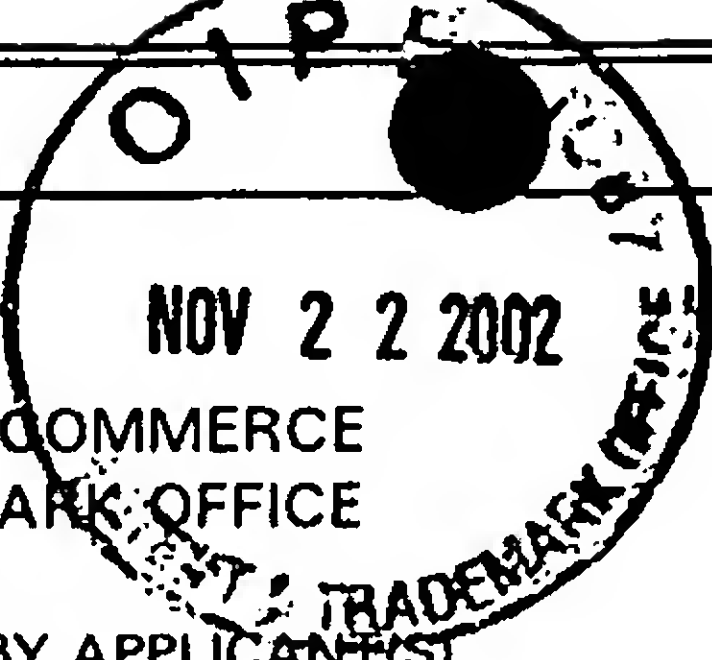
TUA	AO	Iwasa et al., SPIE The International Society for Optical Engineering, 3333, pages 417-424 (1998)
	AP	
	AQ	

EXAMINER

K. Ashita

DATE CONSIDERED

7/31/03

Sheet 1 of 1 FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary) Date Submitted to PTO: November 22, 2002				ATTY DOCKET NO. 2002_0069		SERIAL N . 10/053,622	
APPLICANT Toshikazu TACHIKAWA et al.				FILING DATE January 24, 2002		GROUP 1752	
U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL	AA	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
RA	AA	5,700,625	12/1997	Sato et al.			
UX	AB	6,319,853	11/2001	Ishibashi et al.			
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
UA	AJ	198722	3/1999	KR			
UA	AK	99-66776	8/1999	KR			
	AL						
	AM						
	AN						
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
	AO						
	AP						
	AQ						
EXAMINER <i>R. Ashtu</i>				DATE CONSIDERED 7/31/03			

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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ATTY DOCKET NO.
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10/053,622U.S. DEPARTMENT OF COMMERCE
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Toshikazu TACHIKAWA et al.LIST OF REFERENCES CITED BY APPLICANT(S)
(Use several sheets if necessary)FILING DATE
January 24, 2002GROUP
1752

Date Submitted to PTO: July 23, 2003

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JUL 25 2003
TC 1706

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
RA	AA	5,928,837	7/1999	Sato et al.			
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
	AJ						
	AK						
	AL						
	AM						
	AN						

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

	AO	
	AP	
	AQ	

EXAMINER

RA Ashin

DATE CONSIDERED

7/31/03